Sea	arcn Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/619,608	ABE ET AL.
Examiner	Art Unit
Ellen Kim	2874

SEARCHED					
Class	Subclass	Date	Examiner		
385	14	3/7/2005	EK		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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(INCLUDIN	EARCH NOT	STRATEGY	)
		DATE	EXMR
East		3/7/2005	EK
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